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FDMS7670

October 2014

N-Channel PowerTrench[®] MOSFET 30 V, 3.8 m Ω

Features

- Max $r_{DS(on)} = 3.8 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 21 \text{ A}$
- Max $r_{DS(on)} = 5.0 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 17 \text{ A}$
- Advanced Package and Silicon design for low r_{DS(on)} and high efficiency
- Next generation enhanced body diode technology, engineered for soft recovery. Provides Schottky-like performance with minimum EMI in sync buck converter applications
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

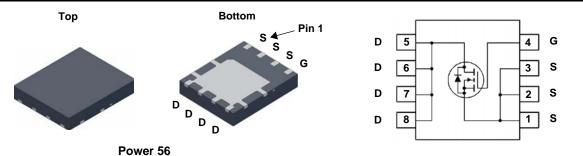


General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency and to minimize switch node ringing of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low $r_{DS(on)}$, fast switching speed and body diode reverse recovery performance.

Applications

- IMVP Vcore Switching for Notebook
- VRM Vcore Switching for Desktop and Server
- OringFET / Load Switch
- DC-DC Conversion



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units
V_{DS}	Drain to Source Voltage			30	V
V_{GS}	Gate to Source Voltage		(Note 4)	±20	V
I _D	Drain Current -Continuous (Package limited)	T _C = 25 °C		42	
	-Continuous (Silicon limited)	T _C = 25 °C		105	^
	-Continuous	T _A = 25 °C	(Note 1a)	21	A
	-Pulsed			150	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	144	mJ
P _D	Power Dissipation	T _C = 25 °C		62	W
	Power Dissipation	T _A = 25 °C	(Note 1a)	2.5	VV
T _J , T _{STG}	Operating and Storage Junction Temperature R	ange		-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case		2.0	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	50	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS7670	FDMS7670	Power 56	13 "	12 mm	3000 units

Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		15		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate to Source Leakage Current, Forward	V _{GS} = 20 V, V _{DS} = 0 V			100	nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1.25	1.9	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		-7		mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 21 A		2.9	3.8	
		$V_{GS} = 4.5 \text{ V}, I_D = 17 \text{ A}$		4.1	5.0	mΩ
		$V_{GS} = 10 \text{ V}, I_D = 21 \text{ A}, T_J = 125 ^{\circ}\text{C}$		4.0	5.3	
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 21 A		136		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 45 V V 0 V	3085	4105	pF
C _{oss}	Output Capacitance	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1 \text{ MHz}$	990	1315	pF
C _{rss}	Reverse Transfer Capacitance	1 = 1 WHZ	75	115	pF
R _a	Gate Resistance		1.2	2.5	Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		15	26	ns
t _r	Rise Time	V _{DD} = 15 V, I _D = 21 A,	6	12	ns
t _{d(off)}	Turn-Off Delay Time	V_{GS} = 10 V, R_{GEN} = 6 Ω	31	50	ns
t _f	Fall Time		5	10	ns
Qg	Total Gate Charge	V _{GS} = 0 V to 10 V	40	56	nC
Qg	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 15 \text{ V}$	17	24	nC
Q _{gs}	Gate to Source Charge	I _D = 21 A	9.8		nC
Q_{gd}	Gate to Drain "Miller" Charge		4.4		nC

Drain-Source Diode Characteristics

Source to Drain Diode, Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 2.1 \text{ A}$ (Note 2)	0.7	0.95	V
Source to Drain blode Forward voltage	V _{GS} = 0 V, I _S = 21 A (Note 2)	0.8	1.1	V
Reverse Recovery Time		38	61	ns
Reverse Recovery Charge		19	34	nC
Reverse Recovery Fall Time	I _F = 21 A, di/dt = 100 A/μs	14		ns
Reverse Recovery Rise Time		24		ns
Softness (t _b /t _a)		1.7		
Reverse Recovery Time	1 21 A di/dt 200 A/v.a	32	51	ns
Reverse Recovery Charge	1F = 21 A, αι/αι = 300 A/μs	34	54	nC
	Reverse Recovery Charge Reverse Recovery Fall Time Reverse Recovery Rise Time Softness (t _b /t _a) Reverse Recovery Time	Source to Drain Diode Forward Voltage $V_{QS} = 0 \text{ V}, I_S = 21 \text{ A}$ (Note 2) Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Fall Time $V_{QS} = 0 \text{ V}, I_S = 21 \text{ A}$ (Note 2) Reverse Recovery Charge $V_{QS} = 0 \text{ V}, I_S = 21 \text{ A}$ (Note 2) Reverse Recovery Fall Time $V_{QS} = 0 \text{ V}, I_S = 21 \text{ A}$ (Note 2)	Source to Drain Diode Forward Voltage $V_{GS} = 0 \text{ V}, V_{IS} = 21 \text{ A}$ (Note 2) 0.8 Reverse Recovery Time 38 Reverse Recovery Charge 19 Reverse Recovery Fall Time 14 Reverse Recovery Rise Time 24 Softness (t_b/t_a) 1.7 Reverse Recovery Time 15 Reverse Recovery Time 17 Reverse Recovery Time 17 $V_{GS} = 0 \text{ V}, V_{IS} = 21 \text{ A}$ (Note 2) 0.8	Source to Drain Diode Forward Voltage $V_{GS} = 0 \text{ V}, I_S = 21 \text{ A}$ (Note 2) 0.8 1.1 Reverse Recovery Time 38 61 Reverse Recovery Charge 19 34 Reverse Recovery Fall Time $I_F = 21 \text{ A}, \text{ di/dt} = 100 \text{ A/µs}$ 1.7 Reverse Recovery Time 24 Softness (t_b/t_a) 1.7 Reverse Recovery Time 37 32 51

^{1.} $R_{\theta,JA}$ is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta,JC}$ is guaranteed by design while $R_{\theta,CA}$ is determined by the user's board design.



a. 50 °C/W when mounted on a 1 in² pad of 2 oz copper.



b. 125 °C/W when mounted on $\,a\,$ minimum pad of 2 oz copper.

^{2.} Pulse Test: Pulse Width < 300 $\mu\text{s},$ Duty cycle < 2.0%.

^{3.} E_{AS} of 144 mJ is based on starting $T_J = 25$ °C, L = 1 mH, $I_{AS} = 17$ A, $V_{DD} = 27$ V, $V_{GS} = 10$ V. 100% test at L = 0.3 mH, $I_{AS} = 22$ A.

^{4.} As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.

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Typical Characteristics $T_J = 25$ °C unless otherwise noted

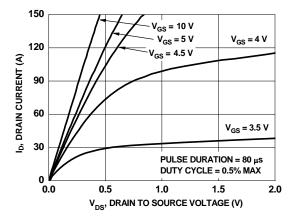


Figure 1. On Region Characteristics

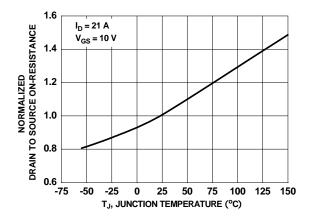


Figure 3. Normalized On Resistance vs Junction Temperature

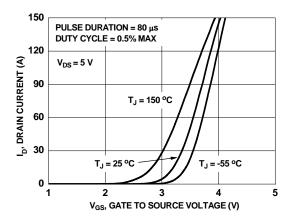


Figure 5. Transfer Characteristics

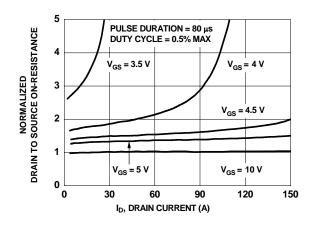


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

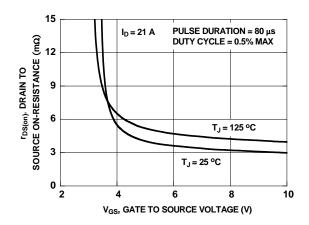


Figure 4. On-Resistance vs Gate to Source Voltage

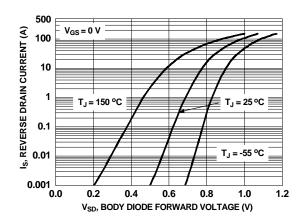


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

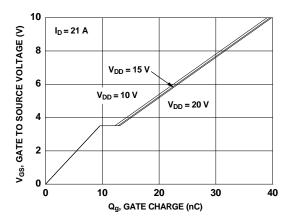


Figure 7. Gate Charge Characteristics

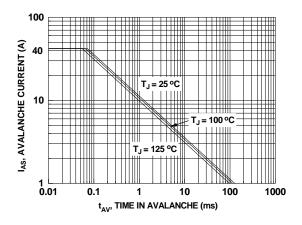


Figure 9. Unclamped Inductive Switching Capability

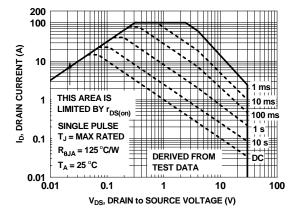


Figure 11. Forward Bias Safe Operating Area

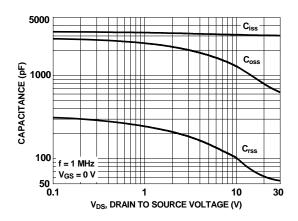


Figure 8. Capacitance vs Drain to Source Voltage

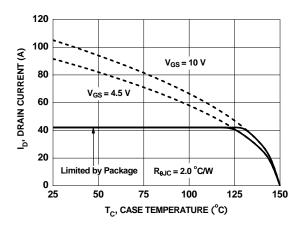


Figure 10. Maximum Continuous Drain Current vs Case Temperature

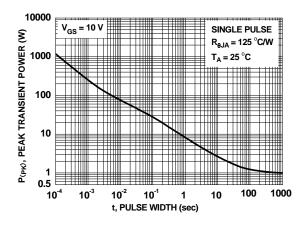


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics $T_J = 25$ °C unless otherwise noted

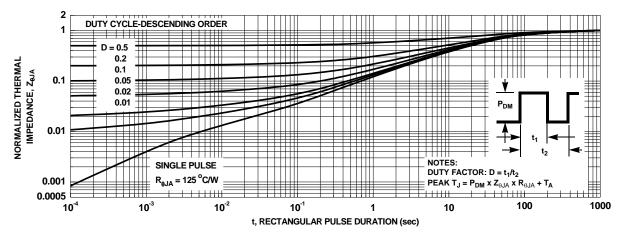


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

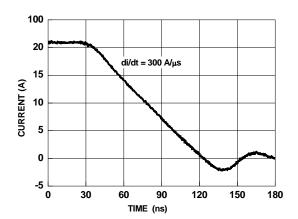


Figure 14. Body Diode Reverse Recovery Characteristics



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